## MC10E158, MC100E158

## 5 V ECL 5-Bit 2:1 Multiplexer

## Description

The MC10E/100E158 contains five $2: 1$ multiplexers with differential outputs. The output data are controlled by the Select input (SEL).

The 100 Series contains temperature compensation.

## Features

- 600 ps Max. D to Output
- 800 ps Max. SEL to Output
- Differential Outputs
- One $\mathrm{V}_{\mathrm{CCO}}$ Pin Per Output Pair
- PECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
- Internal Input $50 \mathrm{k} \Omega$ Pulldown Resistors
- ESD Protection:
- Human Body Model; > 2 kV
- Machine Model; > 200 V
- Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test
- Moisture Sensitivity Level: 3 (Pb-Free)
- For Additional Information, see Application Note AND8003/D
- Flammability Rating:
- UL 94 V-0 @ 0.125 in, Oxygen Index: 28 to 34
- Transistor Count = 126 devices
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

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PLCC-28
FN SUFFIX
CASE 776-02

MARKING DIAGRAM*

xxx = 10 or 100
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
$\mathrm{G} \quad=\mathrm{Pb}$-Free Package
*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

| Device | Package | Shipping ${ }^{\dagger}$ |
| :--- | :---: | :---: |
| MC10E158FNG | PLCC-28 <br> (Pb-Free) | 37 Units/Tube |
| MC10E158FNR2G | PLCC-28 <br> (Pb-Free) | $500 /$ Tape \& Reel |
| MC100E158FNG | PLCC-28 <br> (Pb-Free) | 37 Units/Tube |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.


Figure 1. 28-Lead Pinout

Table 1. PIN DESCRIPTION

| PIN | FUNCTION |
| :--- | :--- |
| $D_{0} a-D_{4} a$ | ECL Input Data $a$ |
| $D_{0} \mathrm{~b}-\mathrm{D}_{4} \mathrm{~b}$ | ECL Input Data b |
| $\mathrm{Q}_{0}-\mathrm{Q}_{4}$ | ECL True Outputs |
| $\bar{Q}_{0}-\bar{Q}_{4}$ | ECL Inverted Outputs |
| SEL | ECL Select Input |
| $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{CCO}}$ | Positive Supply |
| $\mathrm{V}_{\mathrm{EE}}$ | Negative Supply |

Table 2. Logic Diagram

| SEL | Data |
| :---: | :---: |
| H | a |
| L | b |



Figure 2. Logic Diagram

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & V_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{1} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{1} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | $\begin{aligned} & \hline \text { Continuous } \\ & \text { Surge } \end{aligned}$ |  | $\begin{aligned} & \hline 50 \\ & 100 \end{aligned}$ | mA |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Temperature Range |  |  | 0 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{array}{\|l\|} \hline 0 \text { lfpm } \\ 500 \text { lfpm } \end{array}$ | PLCC-28 | $\begin{aligned} & 63.5 \\ & 43.5 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | PLCC-28 | 22 to 26 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) |  |  | 265 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 4. 10E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 33 | 40 |  | 33 | 40 |  | 33 | 40 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3980 | 4070 | 4160 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3050 | 3210 | 3370 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3830 | 3995 | 4160 | 3870 | 4030 | 4190 | 3940 | 4110 | 4280 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3050 | 3285 | 3520 | 3050 | 3285 | 3520 | 3050 | 3302 | 3555 | mV |
| $\mathrm{IIH}^{\text {H }}$ |  |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 5. 10E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1 ))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| IEE | Power Supply Current |  | 33 | 40 |  | 33 | 40 |  | 33 | 40 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1020 | -930 | -840 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1950 | -1790 | -1630 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1170 | -1005 | -840 | -1130 | -970 | -810 | -1060 | -890 | -720 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1950 | -1715 | -1480 | -1950 | -1715 | -1480 | -1950 | -1698 | -1445 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current D SEL |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.065 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 6. 100E SERIES PECL DC CHARACTERISTICS ( $\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $l_{\text {EE }}$ | Power Supply Current |  | 33 | 40 |  | 33 | 40 |  | 38 | 46 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3190 | 3295 | 3380 | 3190 | 3255 | 3380 | 3190 | 3260 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | mV |
| $\mathrm{IIH}^{\text {H }}$ | ```Input HIGH Current D SEL``` |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 7. 100E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCX}}=0 \mathrm{~V} ; \mathrm{V}_{E E}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 33 | 40 |  | 33 | 40 |  | 38 | 46 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1025 | -950 | -880 | -1025 | -950 | -880 | -1025 | -950 | -880 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1810 | -1705 | -1620 | -1810 | -1745 | -1620 | -1810 | -1740 | -1620 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1165 | -1025 | -880 | -1165 | -1025 | -880 | -1165 | -1025 | -880 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current D SEL |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ |  |  | $\begin{aligned} & 200 \\ & 150 \end{aligned}$ | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 8. AC CHARACTERISTICS $\left(\mathrm{V}_{C C x}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ or $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{f}_{\text {MAX }}$ | Maximum Toggle Frequency | 700 | 1100 |  | 700 | 1100 |  | 700 | 1100 |  | MHz |
| $\begin{aligned} & \hline t_{\text {PLH }} \\ & t_{\text {PHL }} \end{aligned}$ | Propagation Delay to Output D SEL | $\begin{aligned} & 250 \\ & 450 \end{aligned}$ | $\begin{aligned} & 500 \\ & 700 \end{aligned}$ | $\begin{aligned} & 650 \\ & 825 \end{aligned}$ | $\begin{aligned} & 250 \\ & 450 \end{aligned}$ | $\begin{aligned} & 500 \\ & 700 \end{aligned}$ | $\begin{aligned} & 650 \\ & 825 \end{aligned}$ | $\begin{aligned} & 250 \\ & 450 \end{aligned}$ | $\begin{aligned} & 500 \\ & 700 \end{aligned}$ | $\begin{aligned} & 650 \\ & 825 \end{aligned}$ | ps |
| $t_{\text {SKEW }}$ | Within-Device Skew (Note 2) |  | 60 |  |  | 60 |  |  | 60 |  | ps |
| $\mathrm{t}_{\text {JITTER }}$ | Random Clock Jitter (RMS) |  | <1 |  |  | <1 |  |  | <1 |  | ps |
| $\mathrm{t}_{\mathrm{r}}$ $\mathrm{t}_{\mathrm{f}}$ | $\begin{gathered} \hline \text { Rise/Fall Time } \\ (20-80 \%) \end{gathered}$ | 275 | 425 | 650 | 275 | 425 | 650 | 275 | 425 | 650 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. 10 Series: $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.

100 Series: VEE can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Within-device skew is defined as identical transitions on similar paths through a device.

## MC10E158, MC100E158



Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices.)

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V)
AN1503/D - ECLinPS $^{\text {M }}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family $^{\text {AN1568/D }}-$ Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10E158, MC100E158

## PACKAGE DIMENSIONS

28 LEAD PLLC
CASE 776-02
ISSUE F


NOTES:

1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE 2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE
2. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE.
. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH
3. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD BURRS, GATE BURRS AND INTERLEAD BURRS, GATE BURRS AND INTERLEAD
FLASH, BUT INCLUDING ANY MISMATCH FLASH, BUT INCLUDING ANY MISMATCH
BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
4. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635)

## MC10E158, MC100E158

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